

Search Notes

Application/Control No.

10/799,607

Examiner

Quoc A. Tran

Applicant(s)/Patent under
Reexamination

YASUDA ET AL.

Art Unit

2176

SEARCHED

Class	Subclass	Date	Examiner
715	512	6/22/2006	
715	505	6/22/2006	
345	619	6/22/2006	
382	310	6/22/2006	

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
INVENTORS SEARCH (i.e. Double Patening)	6/22/2006	
EAST (US-PAT, US-PGPUB, USOCR, EPO, JPO, DERWENT, IBM TDB) see Search Histoty Printout	6/22/2006	
ACM Digital Library see Search History Printout	6/22/2006	